

## OptiMOS® Power-Transistor

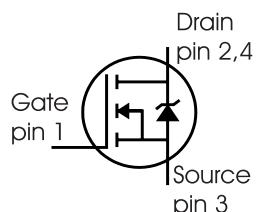
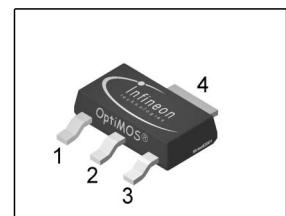
### Feature

- N-Channel
- Enhancement mode
- Logic Level

### Product Summary

$V_{DS}$	55	V
$R_{DS(on)}$	90	$\text{m}\Omega$
$I_D$	2.8	A

SOT 223



Type	Package	Ordering Code	Marking
BSP615S2L	SOT 223	Q67060-S7211	2N615L

**Maximum Ratings**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_A=25^\circ\text{C}$	$I_D$	2.8	A
$T_A=70^\circ\text{C}$		2.3	
Pulsed drain current $T_A=25^\circ\text{C}$	$I_{D \text{ puls}}$	11	
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_A=25^\circ\text{C}$	$P_{\text{tot}}$	1.8	W
Operating and storage temperature	$T_j, T_{\text{stg}}$	-55... +150	°C
IEC climatic category; DIN IEC 68-1		55/150/00	

**Thermal Characteristics**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Characteristics</b>					
Thermal resistance, junction - soldering point (Pin 4)	$R_{thJS}$	-	19	23	K/W
Thermal resistance, chip to ambient air: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>1)</sup>	$R_{thJA}$	-	-	120	
		-	-	70	

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Static Characteristics</b>					
Drain-source breakdown voltage $V_{GS}=0\text{V}, I_D=1\text{mA}$	$V_{(BR)DSS}$	55	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=12\mu\text{A}$	$V_{GS(\text{th})}$	1.2	1.6	2	
Zero gate voltage drain current $V_{DS}=55\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$ $V_{DS}=55\text{V}, V_{GS}=0\text{V}, T_j=125^\circ\text{C}^2)$	$I_{DSS}$	-	0.1	1	$\mu\text{A}$
-		-	10	100	
Gate-source leakage current $V_{GS}=20\text{V}, V_{DS}=0\text{V}$	$I_{GSS}$	-	10	100	nA
Drain-source on-state resistance $V_{GS}=4.5\text{V}, I_D=1.4\text{A}$	$R_{DS(\text{on})}$	-	86	150	$\text{m}\Omega$
Drain-source on-state resistance $V_{GS}=10\text{V}, I_D=1.4\text{A}$	$R_{DS(\text{on})}$	-	67	90	

<sup>1</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

<sup>2</sup>Defined by design. Not subject to production test.

**Electrical Characteristics**

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic Characteristics**

Transconductance	$g_{fs}$	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ $I_D = 2.3A$	2.7	5.4	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 25V,$ $f = 1MHz$	-	249	330	pF
Output capacitance	$C_{oss}$		-	58	78	
Reverse transfer capacitance	$C_{rss}$		-	22	33	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30V, V_{GS} = 4.5V,$ $I_D = 2.8A,$ $R_G = 24\Omega$	-	7.8	12	ns
Rise time	$t_r$		-	24	36	
Turn-off delay time	$t_{d(off)}$		-	22	33	
Fall time	$t_f$		-	23	34	

**Gate Charge Characteristics**

Gate to source charge	$Q_{gs}$	$V_{DD} = 40V, I_D = 2.8A$	-	0.8	1.1	nC
Gate to drain charge	$Q_{gd}$		-	2.5	3.8	
Gate charge total	$Q_g$	$V_{DD} = 40V, I_D = 2.8A,$ $V_{GS} = 0 \text{ to } 10V$	-	7.5	10	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 40V, I_D = 2.8A$	-	3	-	V

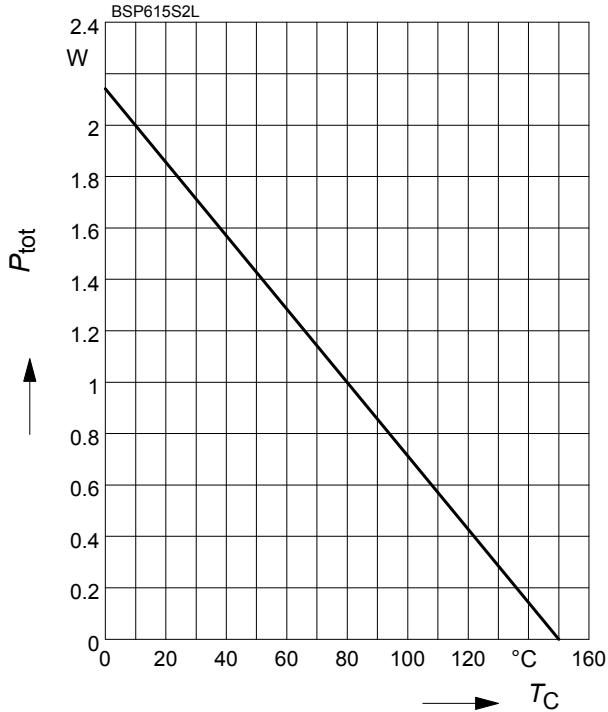
**Reverse Diode**

Inverse diode continuous forward current	$I_S$	$T_A = 25^\circ C$	-	-	2.8	A
Inv. diode direct current, pulsed	$I_{SM}$		-	-	11	
Inverse diode forward voltage	$V_{SD}$	$V_{GS} = 0V, I_F = 2.8A$	-	0.8	1.1	V
Reverse recovery time	$t_{rr}$	$V_R = 30V, I_F = I_S,$ $di_F/dt = 100A/\mu s$	-	30	38	ns
Reverse recovery charge	$Q_{rr}$		-	30	38	

## 1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$

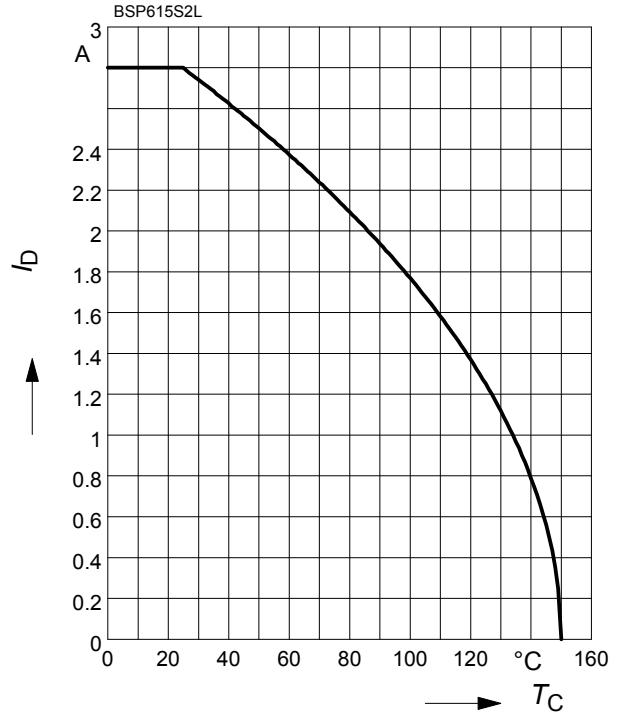
parameter:  $V_{GS} \geq 4 \text{ V}$



## 2 Drain current

$$I_D = f(T_C)$$

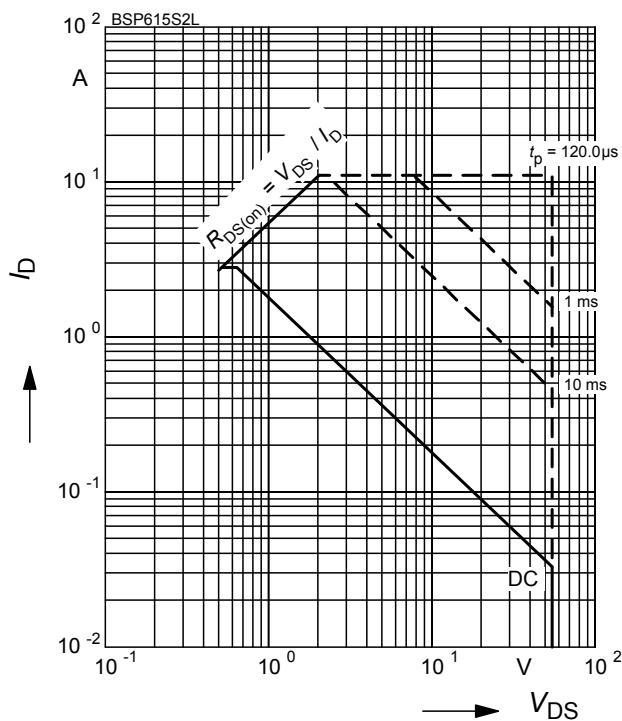
parameter:  $V_{GS} \geq 10 \text{ V}$



## 3 Safe operating area

$$I_D = f(V_{DS})$$

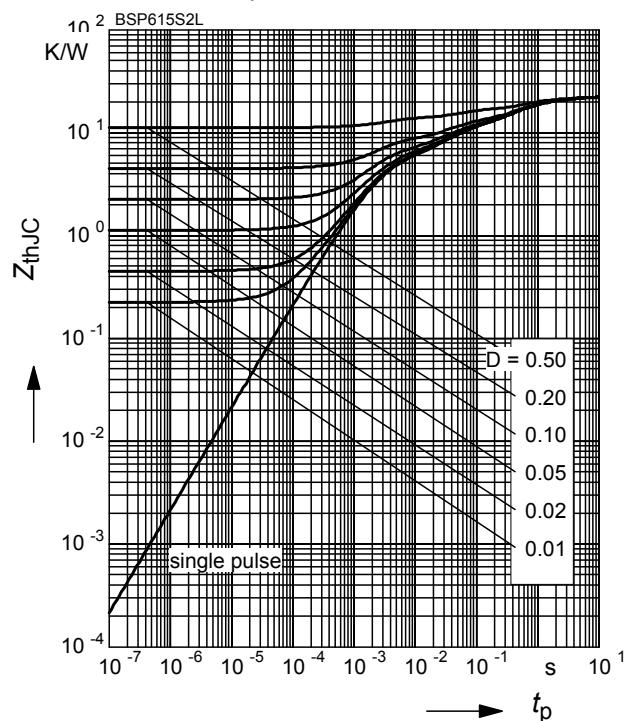
parameter :  $D = 0$  ,  $T_C = --$



## 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

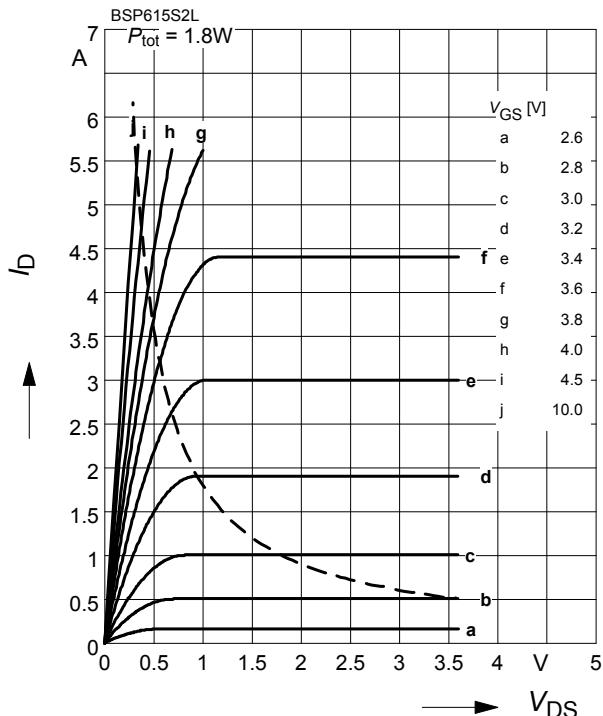
parameter :  $D = t_p/T$



### 5 Typ. output characteristic

$$I_D = f(V_{DS}); \quad T_j=25^\circ\text{C}$$

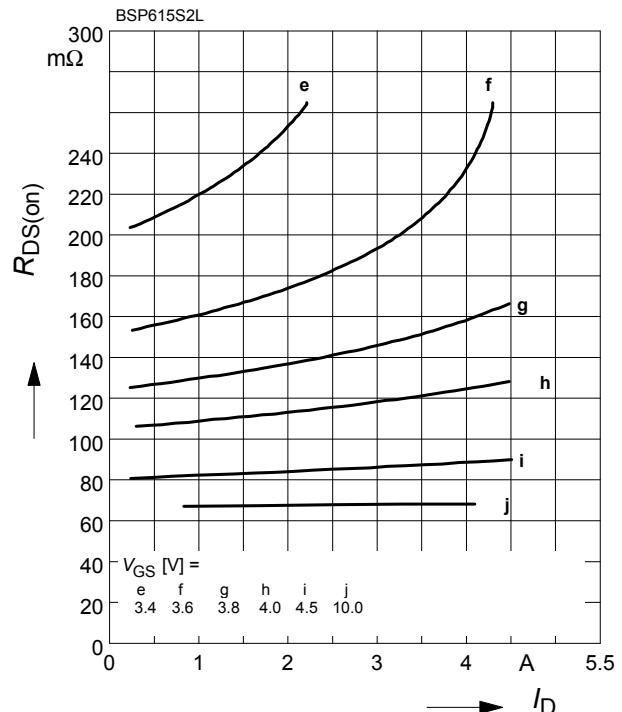
parameter:  $t_p = 80 \mu\text{s}$



### 6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

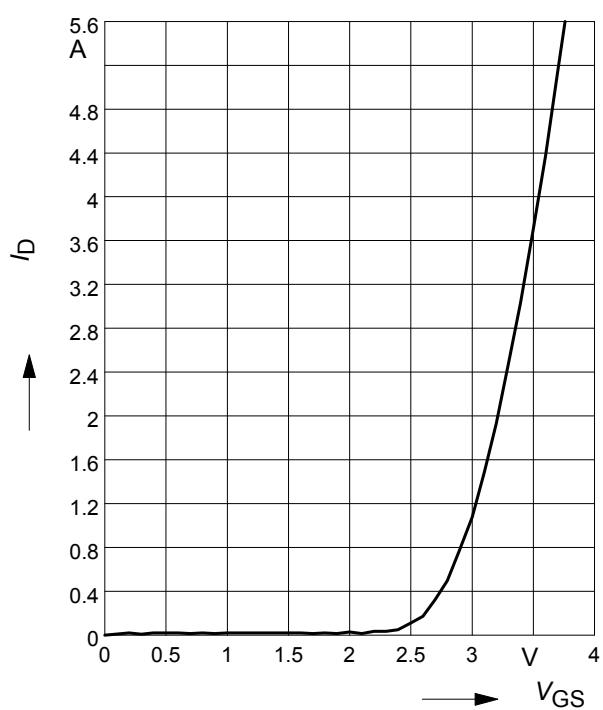
parameter:  $V_{GS}$



### 7 Typ. transfer characteristics

$$I_D = f(V_{GS}); \quad V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$$

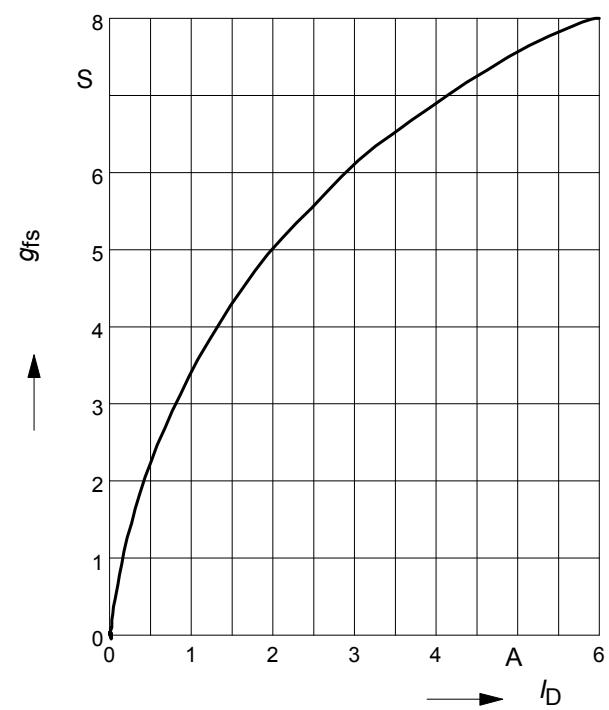
parameter:  $t_p = 80 \mu\text{s}$



### 8 Typ. forward transconductance

$$g_{fs} = f(I_D); \quad T_j=25^\circ\text{C}$$

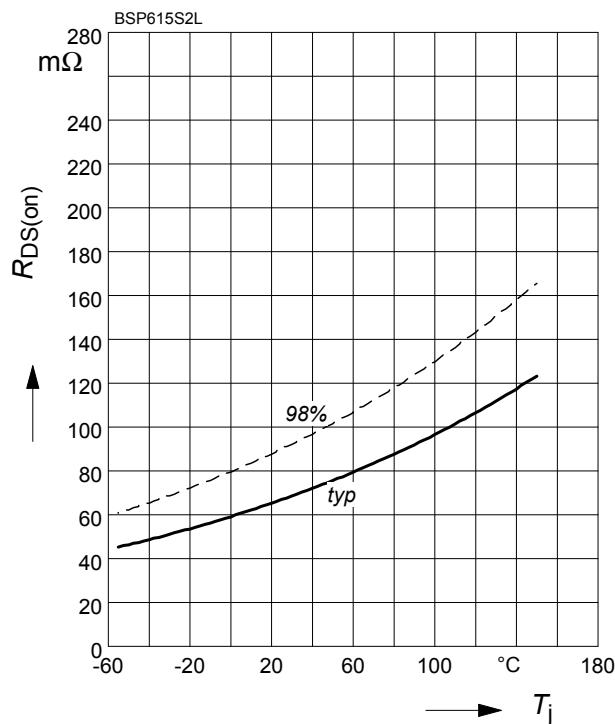
parameter:  $g_{fs}$



### 9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

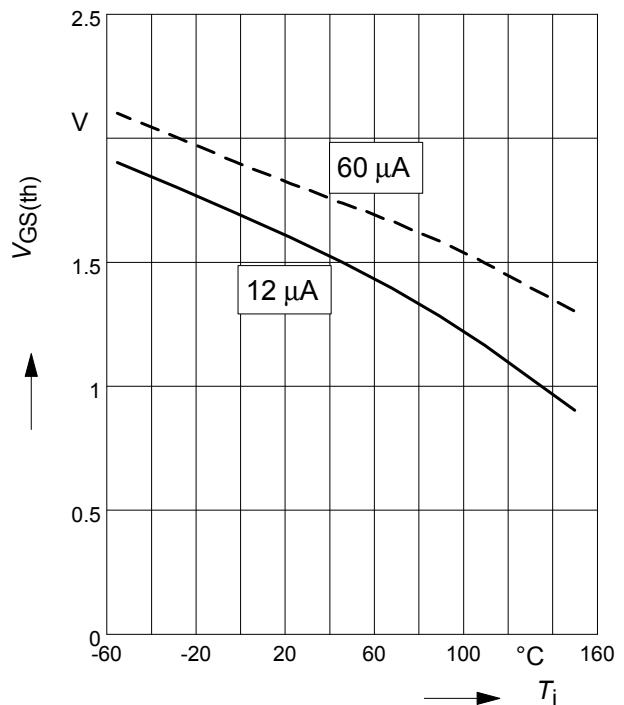
parameter :  $I_D = 1.4 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

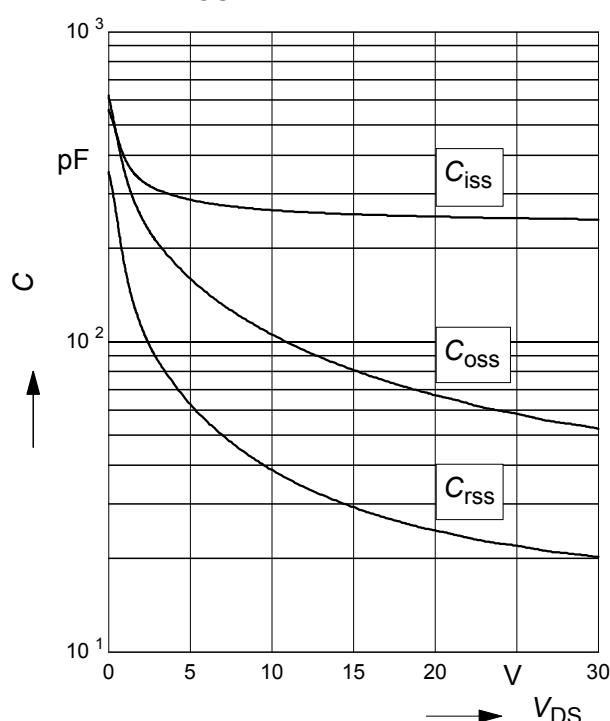
parameter:  $V_{GS} = V_{DS}$



### 11 Typ. capacitances

$$C = f(V_{DS})$$

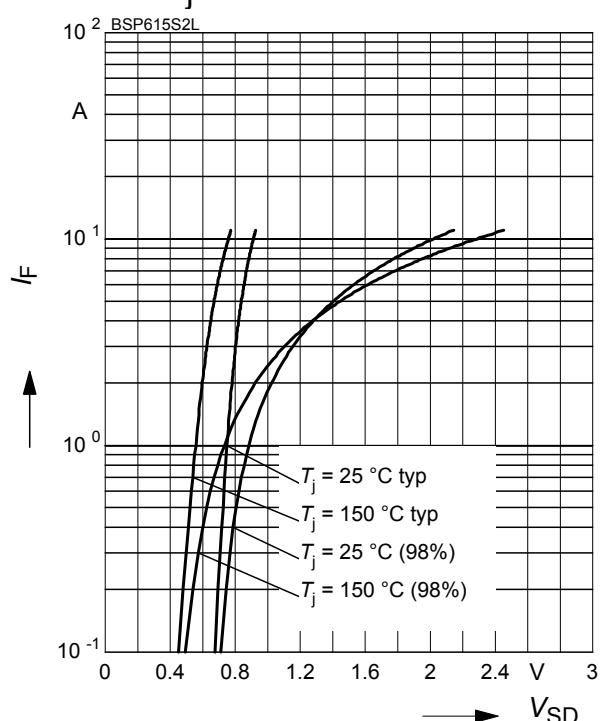
parameter:  $V_{GS}=0\text{V}$ ,  $f=1 \text{ MHz}$



### 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

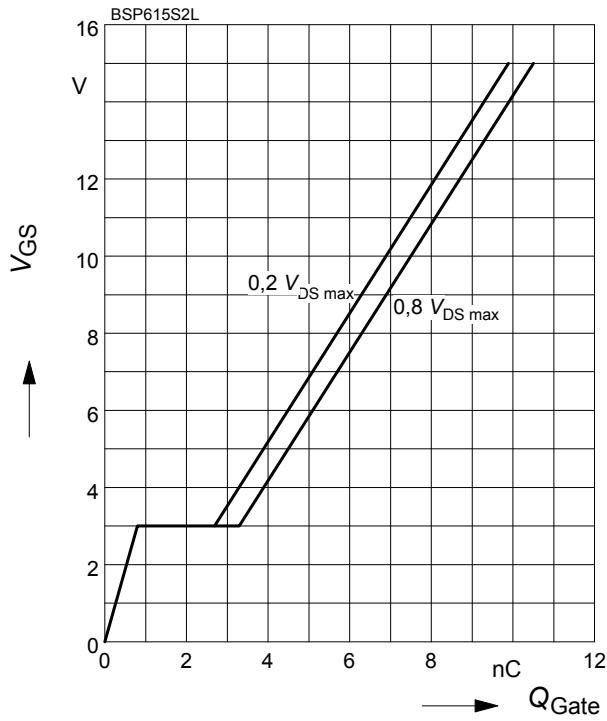
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



### 13 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

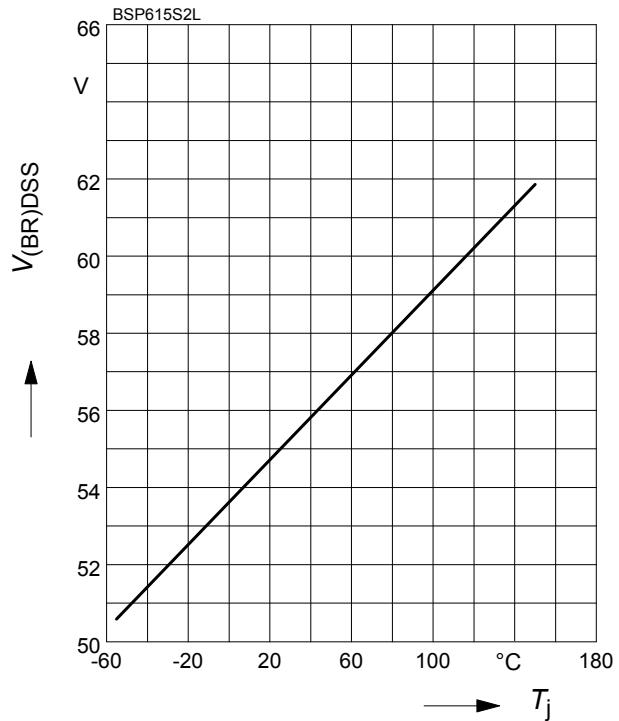
parameter:  $I_D = 2.8 \text{ A pulsed}$



### 14 Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$

parameter:  $I_D = 10 \text{ mA}$



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